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| <b>Search Notes</b><br> | <b>Application/Control No.</b><br>10624759 | <b>Applicant(s)/Patent Under Reexamination</b><br>WEN ET AL. |
|   | <b>Examiner</b><br>Ahn, Sangwoo            | <b>Art Unit</b><br>2166                                      |

| SEARCHED |          |      |          |
|----------|----------|------|----------|
| Class    | Subclass | Date | Examiner |
|          |          |      |          |

| SEARCH NOTES                                  |           |          |
|---|-----------|----------|
| Search Notes                                  | Date      | Examiner |
| EAST updated (see search history printout(s)) | 12/5/2007 | SW       |

| INTERFERENCE SEARCH |          |      |          |
|---------------------|----------|------|----------|
| Class               | Subclass | Date | Examiner |
|                     |          |      |          |